

P-Channel 150 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 150			
$R_{DS(on)}(\Omega)$ at V_{GS} = - 10 V	0.065			
$R_{DS(on)}(\Omega)$ at V_{GS} = - 4.5 V	0.070			
I _D (A)	- 40			
Configuration	Single			

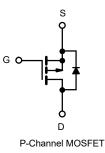
FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- Package with Low Thermal Resistance
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC





TO-220



ABSOLUTE MAXIMUM RATING	S (T _C = 25 °C, unless	otherwise noted	4)		
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	- 150		
Gate-Source Voltage		V _{GS}	± 20	V	
Continuous Drain Current	T _C = 25 °C	I	- 40		
	T _C = 125 °C	Ι _D	- 25		
Continuous Source Current (Diode Conducti	I _S	- 25	А		
Pulsed Drain Current ^b		I _{DM}	- 55		
Single Pulse Avalanche Current		I _{AS}	- 22		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	103	mJ	
	T _C = 25 °C	D_	75	W	
Maximum Power Dissipation ^b	T _C = 125 °C	P _D	37	vv	
Operating Junction and Storage Temperatur	re Range	T _J , T _{stg}	- 55 to + 175	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-Ambient	PCB Mount ^c	R _{thJA}	50	°C/W		
Junction-to-Case (Drain)	ction-to-Case (Drain)		1.1	0/10		

Notes

- a. Package limited.
- b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- c. When mounted on 1" square PCB (FR-4 material).
- d. Parametric verification ongoing.

SPECIFICATIONS ($T_c = 25 \text{ °C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$		- 150	-	I	V
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$		-	-3.5	
Gate-Source Leakage	I _{GSS}	V _{DS} =	$V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 20 \text{ V}$		-	± 100	nA
		$V_{GS} = 0 V$	V _{DS} = - 100 V	-	-	- 1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	V_{DS} = - 100 V, T _J = 125 °C	-	-	- 50	μA
		$V_{GS} = 0 V$	V_{DS} = - 100 V, T _J = 175 °C	I	-	- 250	
On-State Drain Current ^a	I _{D(on)}	$V_{GS} = -10 V$	$V_{DS} \le$ - 5 V	- 30	-	-	А
		$V_{GS} = -10 V$	I _D = - 9 A	-	0.065	-	Ω
Ducin Source On State Desistence	Brach	V_{GS} = - 10 V	I_D = - 9 A, T_J = 125 °C	-	0.088	-	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -10 V$	I _D = - 9 A, T _J = 175 °C	-	-	0.113	
		$V_{GS} = -4.5 V$	I _D = - 7.7 A	-	0.07	-	
Forward Transconductanceb	9 _{fs}	V _{DS} =	V _{DS} = - 15 V, I _D = - 9.2 A		35	-	S
Dynamic ^b							
Input Capacitance	C _{iss}			-	5000	-	
Output Capacitance	C _{oss}	$V_{GS} = 0 V$	= 0 V V _{DS} = - 25 V, f = 1 MHz	-	301	380	pF
Reverse Transfer Capacitance	C _{rss}			-	208	260	
Total Gate Charge ^c	Qg			-	96	144	
Gate-Source Charge ^c	Q _{gs}	V _{GS} = - 10 V	$V_{DS} = -50V, I_{D} = -9.2 \text{ A}$	-	8.4	-	nC
Gate-Drain Charge ^c	Q _{gd}			-	23.5	-	
Gate Resistance	Rg	f = 1 MHz		1.5	3.13	4.7	Ω
Turn-On Delay Time ^c	t _{d(on)}	V_{DD} = - 50 V, R _L = 6.49 Ω I _D \cong - 7.7 A, V _{GEN} = - 10 V, R _g = 1.0 Ω		-	11	17	- ns
Rise Time ^c	t _r			-	11	17	
Turn-Off Delay Time ^c	t _{d(off)}			-	78	117	
Fall Time ^c	t _f			-	15	23	
Source-Drain Diode Ratings and Chara	acteristics ^b						
Pulsed Current ^a	I _{SM}			-	-	- 50	А
Forward Voltage	V _{SD}	I _F = - 7.7 A, V _{GS} = 0 V		-	- 0.8	- 1.5	V

Notes

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

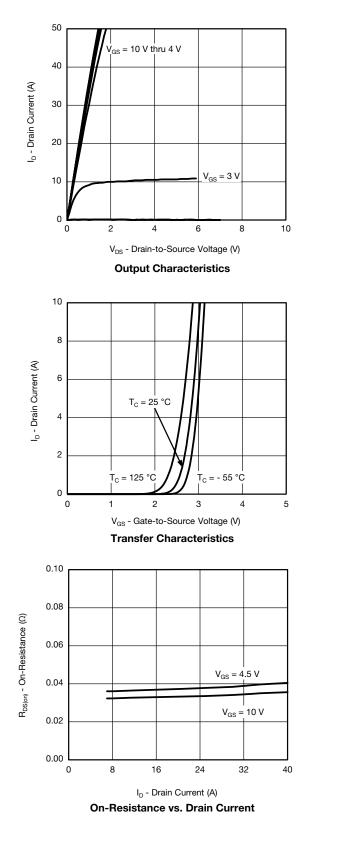
c. Independent of operating temperature.

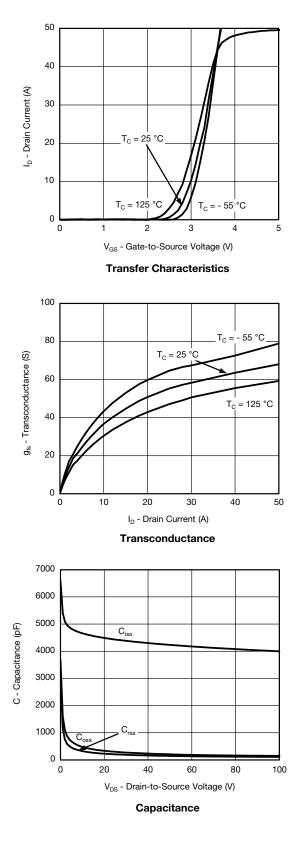
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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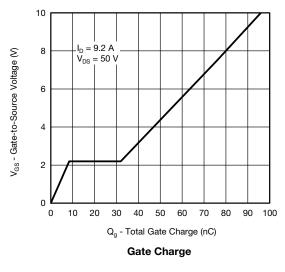
TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)

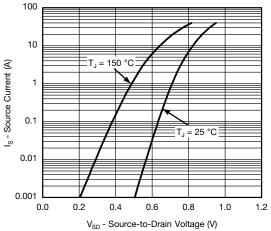




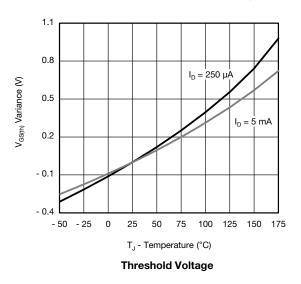


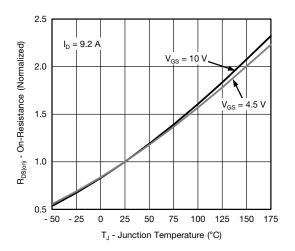
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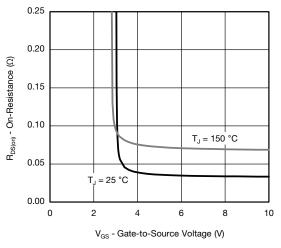


Source Drain Diode Forward Voltage

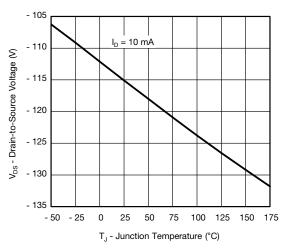




On-Resistance vs. Junction Temperature



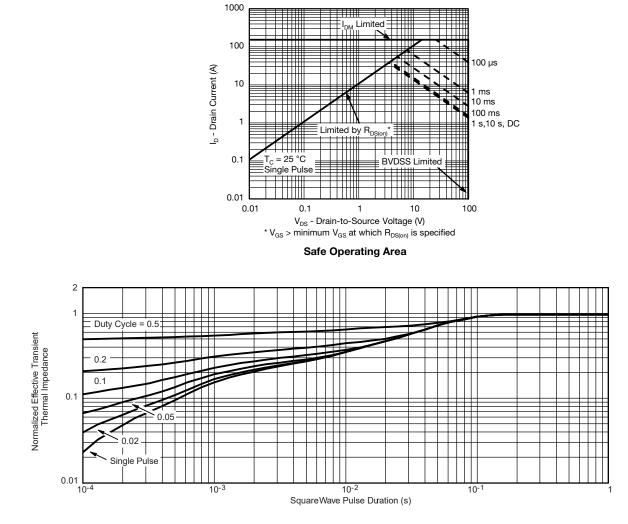
On-Resistance vs. Gate-to-Source Voltage



Drain Source Breakdown vs. Junction Temperature



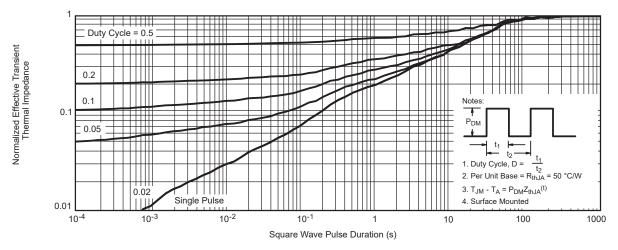
THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case



THERMAL RATINGS ($T_A = 25 \text{ °C}$, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

Note

• The characteristics shown in the two graphs

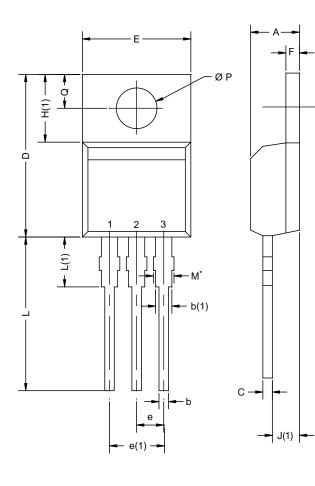
- Normalized Transient Thermal Impedance Junction to Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction to Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-220AB



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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